Special Issue

Industrial AI: Applications in Fault Detection, Diagnosis, and Prognosis

Message from the Guest Editors

In the fourth industrial revolution, or Industry 4.0, a key objective is to enhance equipment's ability to perceive its own health state and predict future behavior. The development of artificial intelligence, especially the progress made in deep learning, in the recent decade provides a promising tool in bolstering this enhancement. Such a tool can be a complement or alternative to conventional physics-based and signalprocessing-based techniques in fault detection, diagnosis and prognosis applications. Researchers have started to build data-driven or hybrid models to further boost their prediction accuracy in the above applications, yet there are still some untouched or underexplored territories, such as causal inference, demystifying the black-box modelling, domain adaptation, automatic feature learning, etc. This special issue is to present current innovations and engineering achievements of scientists and industrial practitioners in the area of adopting artificial intelligence techniques in fault detection, diagnosis and prognosis.

Guest Editors

Dr. Janet Lin

Dr. Liangwei Zhang

Dr. Haidong Shao

Deadline for manuscript submissions

closed (31 January 2024)



Applied Sciences

an Open Access Journal by MDPI

Impact Factor 2.5 CiteScore 5.5



mdpi.com/si/100241

Applied Sciences Editorial Office MDPI, Grosspeteranlage 5 4052 Basel, Switzerland Tel: +41 61 683 77 34 applsci@mdpi.com

mdpi.com/journal/applsci





Applied Sciences

an Open Access Journal by MDPI

Impact Factor 2.5 CiteScore 5.5



About the Journal

Message from the Editor-in-Chief

As the world of science becomes ever more specialized, researchers may lose themselves in the deep forest of the ever increasing number of subfields being created. This open access journal Applied Sciences has been started to link these subfields, so researchers can cut through the forest and see the surrounding, or quite distant fields and subfields to help develop his/her own research even further with the aid of this multi-dimensional network.

Editor-in-Chief

Prof. Dr. Giulio Nicola Cerullo

Dipartimento di Fisica, Politecnico di Milano, Piazza L. da Vinci 32, 20133 Milano, Italy

Author Benefits

Open Access:

free for readers, with article processing charges (APC) paid by authors or their institutions.

High Visibility:

indexed within Scopus, SCIE (Web of Science), Ei Compendex, Inspec, CAPlus / SciFinder, and other databases.

Journal Rank:

JCR - Q2 (Engineering, Multidisciplinary) / CiteScore - Q1 (General Engineering)

